

Notice of References Cited

Application/Control No.

09/520,257

Applicant(s)/Patent Under
Reexamination
BILAK ET AL.

Examiner

Herng-der Day

Art Unit

2123

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,356,861	03-2002	Singhal et al.	703/2
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NON-PATENT DOCUMENTS

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	V	Comard et al., "Calculating Error of Measurement on High Speed Microprocessor Test", Proceedings of International Test Conference, October 1994, pages 793-801.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.